

# OPAx314 3-MHz, Low-Power, Low-Noise, RRIO, 1.8-V CMOS Operational Amplifier

## 1 Features

- Low  $I_Q$ : 150  $\mu\text{A}/\text{ch}$
- Wide Supply Range: 1.8 V to 5.5 V
- Low Noise: 14  $\text{nV}/\sqrt{\text{Hz}}$  at 1 kHz
- Gain Bandwidth: 3 MHz
- Low Input Bias Current: 0.2 pA
- Low Offset Voltage: 0.5 mV
- Unity-Gain Stable
- Internal RF/EMI Filter
- Extended Temperature Range:  $-40^\circ\text{C}$  to  $125^\circ\text{C}$

## 2 Applications

- Battery-Powered Instruments:
  - Consumer, Industrial, Medical
  - Notebooks, Portable Media Players
- Photodiode Amplifiers
- Active Filters
- Remote Sensing
- Wireless Metering
- Handheld Test Equipment

## 3 Description

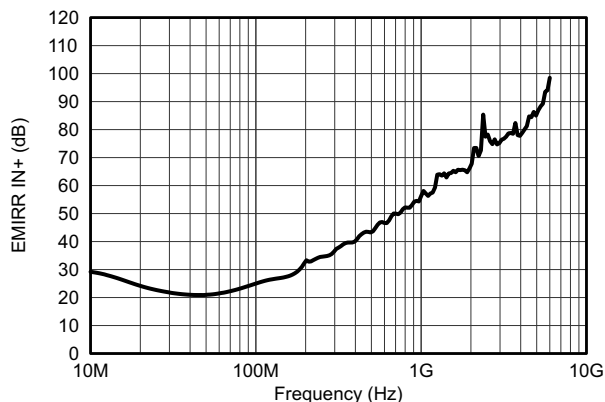
The OPA314 family of single-, dual-, and quad-channel operational amplifiers represents a new generation of low-power, general-purpose CMOS amplifiers. Rail-to-rail input and output swings, low quiescent current (150  $\mu\text{A}$  typically at 5  $V_S$ ) combined with a wide bandwidth of 3 MHz, and very low noise (14  $\text{nV}/\sqrt{\text{Hz}}$  at 1 kHz) make this family very attractive for a variety of battery-powered applications that require a good balance between cost and performance. The low input bias current supports applications with  $\text{M}\Omega$  source impedances.

The robust design of the OPA314 devices provides ease-of-use to the circuit designer: unity-gain stability with capacitive loads of up to 300 pF, an integrated RF/EMI rejection filter, no phase reversal in overdrive conditions, and high electrostatic discharge (ESD) protection (4-kV HBM).

These devices are optimized for low-voltage operation as low as 1.8 V ( $\pm 0.9$  V) and up to 5.5 V ( $\pm 2.75$  V), and are specified over the full extended temperature range of  $-40^\circ\text{C}$  to  $125^\circ\text{C}$ .

The OPA314 (single) is available in both SC70-5 and SOT23-5 packages. The OPA2314 (dual) is offered in SO-8, MSOP-8, and DFN-8 packages. The quad-channel OPA4314 is offered in a TSSOP-14 package.

EMIRR vs Frequency



Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
OPA314	SOT-23 (5)	2.90 mm × 1.60 mm
	SC70 (5)	2.00 mm × 1.25 mm
OPA2314	VSSOP (8)	3.00 mm × 3.00 mm
	SOIC (8)	4.90 mm × 3.91 mm
	VSON (8)	3.00 mm × 3.00 mm
OPA4314	TSSOP (14)	5.00 mm × 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

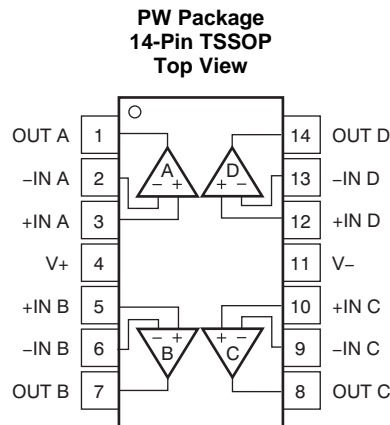
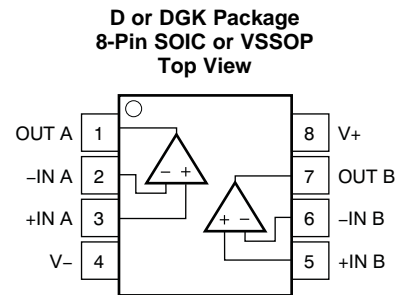
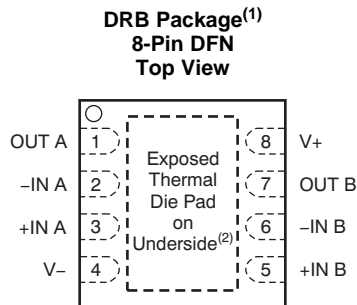
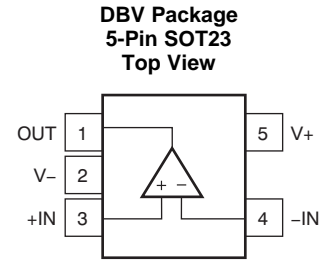
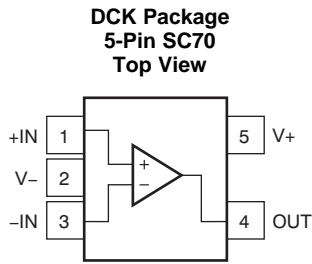




**Changes from Revision A (August 2011) to Revision B****Page**

- 
- Deleted shading from OPA2314 MSOP-8 row in Package Information table ..... [1](#)
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## 5 Pin Configuration and Functions



(1) Pitch: 0.65 mm.

(2) Connect thermal pad to V-. Pad size: 1.8 mm × 1.5 mm.

### Pin Functions: OPA314

NAME	PIN		I/O	DESCRIPTION
	DBV	DCK		
+IN	3	1	I	Noninverting input
-IN	4	3	I	Inverting input
OUT	1	4	O	Output
V+	5	5	—	Positive (highest) supply
V-	2	2	—	Negative (lowest) supply

**Pin Functions: OPA2314**

NAME	PIN			I/O	DESCRIPTION
	DRB	DGK	D		
+IN A	3	3	3	I	Noninverting input
+IN B	5	5	5	I	Noninverting input
–IN A	2	2	2	I	Inverting input
–IN B	6	6	6	I	Inverting input
OUT A	1	1	1	O	Output
OUT B	7	7	7	O	Output
V+	8	8	8	—	Positive (highest) supply
V–	4	4	4	—	Negative (lowest) supply

**Pin Functions: OPA4314**

NAME	PIN		I/O	DESCRIPTION
	NO.			
+IN A	3		I	Noninverting input
+IN B	5		I	Noninverting input
+IN C	10		I	Noninverting input
+IN D	12		I	Noninverting input
–IN A	2		I	Inverting input
–IN B	6		I	Inverting input
–IN C	9		I	Inverting input
–IN D	13		I	Inverting input
OUT A	1		O	Output
OUT B	7		O	Output
OUT C	8		O	Output
OUT D	14		O	Output
V+	4		—	Positive (highest) supply
V–	11		—	Negative (lowest) supply

## 6 Specifications

### 6.1 Absolute Maximum Ratings

Over operating free-air temperature range, unless otherwise noted.<sup>(1)</sup>

		MIN	MAX	UNIT
Supply voltage		7		V
Signal input terminals	Voltage <sup>(2)</sup>	(V–) – 0.5	(V+) + 0.5	V
	Current <sup>(2)</sup>	–10	10	mA
Output short-circuit <sup>(3)</sup>		Continuous		mA
Operating temperature, T <sub>A</sub>		–40	150	°C
Junction temperature, T <sub>J</sub>				°C
Storage temperature, T <sub>stg</sub>		–65	150	°C

- (1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.
- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5 V beyond the supply rails should be current limited to 10 mA or less.
- (3) Short-circuit to ground, one amplifier per package.

### 6.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub> Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±4000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000	
	Machine model (MM)	±200	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V <sub>S</sub>	Supply voltage	1.8 (±0.9)		5.5 (±2.75)	V
T <sub>A</sub>	Ambient operating temperature	–40		125	°C

### 6.4 Thermal Information: OPA314

THERMAL METRIC <sup>(1)</sup>	OPA314			UNIT	
	DBV (SOT23)	DCK (SC70)	DRL (SOT553)		
	5 PINS	5 PINS	5 PINS		
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	228.5	281.4	208.1	°C/W
R <sub>θJC(top)</sub>	Junction-to-case(top) thermal resistance	99.1	91.6	0.1	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	54.6	59.6	42.4	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	7.7	1.5	0.5	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	53.8	58.8	42.2	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 6.5 Thermal Information: OPA2314

THERMAL METRIC <sup>(1)</sup>		OPA2314			UNIT
		D (SO)	DGK (MSOP)	DRB (DFN)	
		8 PINS	8 PINS	8 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	138.4	191.2	53.8	°C/W
R <sub>θJC(top)</sub>	Junction-to-case(top) thermal resistance	89.5	61.9	69.2	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	78.6	111.9	20.1	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	29.9	5.1	3.8	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	78.1	110.2	11.6	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 6.6 Thermal Information: OPA4314

THERMAL METRIC <sup>(1)</sup>		OPA4314		UNIT
		D (SOIC)	PW (TSSOP)	
		14 PINS	14 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	93.2	121	°C/W
R <sub>θJC(top)</sub>	Junction-to-case(top) thermal resistance	51.8	49.4	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	49.4	62.8	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	13.5	5.9	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	42.2	62.2	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 6.7 Electrical Characteristics

V<sub>S</sub> = 1.8 V to 5.5 V; At T<sub>A</sub> = 25 °C, R<sub>L</sub> = 10 kΩ connected to V<sub>S</sub>/2, V<sub>CM</sub> = V<sub>S</sub>/2, and V<sub>OUT</sub> = V<sub>S</sub>/2, unless otherwise noted.<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	T <sub>A</sub> = 25 °C			T <sub>A</sub> = –40°C to 125°C			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
<b>OFFSET VOLTAGE</b>								
V <sub>OS</sub>	Input offset voltage	V <sub>CM</sub> = (V <sub>S+</sub> ) – 1.3 V		0.5	2.5			mV
dV <sub>OS</sub> /dT	vs Temperature					1		μV/°C
PSRR	vs power supply	V <sub>CM</sub> = (V <sub>S+</sub> ) – 1.3 V		78	92			dB
	Over temperature					74		dB
	Channel separation, DC	At DC		10				μV/V
<b>INPUT VOLTAGE RANGE</b>								
V <sub>CM</sub>	Common-mode voltage range			(V <sub>–</sub> ) – 0.2	(V <sub>+</sub> ) + 0.2			V
CMRR	Common-mode rejection ratio	V <sub>S</sub> = 1.8 V to 5.5 V, (V <sub>S–</sub> ) – 0.2 V < V <sub>CM</sub> < (V <sub>S+</sub> ) – 1.3 V		75	96			dB
		V <sub>S</sub> = 5.5 V, V <sub>CM</sub> = –0.2 V to 5.7 V <sup>(2)</sup>		66	80			dB
	Over temperature	V <sub>S</sub> = 1.8 V, (V <sub>S–</sub> ) – 0.2 V < V <sub>CM</sub> < (V <sub>S+</sub> ) – 1.3 V				70	86	dB
		V <sub>S</sub> = 5.5 V, (V <sub>S–</sub> ) – 0.2 V < V <sub>CM</sub> < (V <sub>S+</sub> ) – 1.3 V				73	90	dB
		V <sub>S</sub> = 5.5 V, V <sub>CM</sub> = –0.2 V to 5.7 V <sup>(2)</sup>				60		dB
<b>INPUT BIAS CURRENT</b>								
I <sub>B</sub>	Input bias current			±0.2	±10			pA
	Over temperature						±600	pA
I <sub>OS</sub>	Input offset current			±0.2	±10			pA
	Over temperature						±600	pA
<b>NOISE</b>								
	Input voltage noise (peak-to-peak)	f = 0.1 Hz to 10 Hz		5				μV <sub>PP</sub>

(1) Parameters with minimum or maximum specification limits are 100% production tested at +25°C, unless otherwise noted. Over temperature limits are based on characterization and statistical analysis.

(2) Specified by design and characterization; not production tested.

**Electrical Characteristics (continued)**
 $V_S = 1.8\text{ V to }5.5\text{ V}$ ; At  $T_A = 25\text{ }^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.<sup>(1)</sup>

PARAMETER		TEST CONDITIONS	T <sub>A</sub> = 25 °C			T <sub>A</sub> = –40°C to 125°C			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
e <sub>n</sub>	Input voltage noise density	f = 10 kHz	13						nV/√Hz
		f = 1 kHz	14						nV/√Hz
i <sub>n</sub>	Input current noise density	f = 1 kHz	5						fA/√Hz
<b>INPUT CAPACITANCE</b>									
C <sub>IN</sub>	Differential	V <sub>S</sub> = 5 V	1						pF
	Common-mode	V <sub>S</sub> = 5 V	5						pF
<b>OPEN-LOOP GAIN</b>									
A <sub>OL</sub>	Open-loop voltage gain	V <sub>S</sub> = 1.8 V, 0.2 V < V <sub>O</sub> < (V+) – 0.2 V, R <sub>L</sub> = 10 kΩ	90	115					dB
		V <sub>S</sub> = 5.5 V, 0.2 V < V <sub>O</sub> < (V+) – 0.2 V, R <sub>L</sub> = 10 kΩ	100	128					dB
		V <sub>S</sub> = 1.8 V, 0.5 V < V <sub>O</sub> < (V+) – 0.5 V, R <sub>L</sub> = 2 kΩ <sup>(2)</sup>	90	100					dB
		V <sub>S</sub> = 5.5 V, 0.5 V < V <sub>O</sub> < (V+) – 0.5 V, R <sub>L</sub> = 2 kΩ <sup>(2)</sup>	94	110					dB
Over temperature		V <sub>S</sub> = 5.5 V, 0.2 V < V <sub>O</sub> < (V+) – 0.2 V, R <sub>L</sub> = 10 kΩ				90	110	dB	
		V <sub>S</sub> = 5.5 V, 0.5 V < V <sub>O</sub> < (V+) – 0.2 V, R <sub>L</sub> = 2 kΩ				100		dB	
Phase margin		V <sub>S</sub> = 5 V, G = 1, R <sub>L</sub> = 10 kΩ	65						°
<b>FREQUENCY RESPONSE</b>									
GBW	Gain-bandwidth product	V <sub>S</sub> = 1.8 V, R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 10 pF	2.7						MHz
		V <sub>S</sub> = 5 V, R <sub>L</sub> = 10 kΩ, C <sub>L</sub> = 10 pF	3						MHz
SR	Slew rate <sup>(3)</sup>	V <sub>S</sub> = 5 V, G = 1	1.5						V/μs
t <sub>S</sub>	Settling time	To 0.1%, V <sub>S</sub> = 5 V, 2-V step, G = 1	2.3						μs
		To 0.01%, V <sub>S</sub> = 5 V, 2-V step, G = 1	3.1						μs
Overload recovery time		V <sub>S</sub> = 5 V, V <sub>IN</sub> × Gain > V <sub>S</sub>	5.2						μs
THD+N	Total harmonic distortion + noise <sup>(4)</sup>	V <sub>S</sub> = 5 V, V <sub>O</sub> = 1 V <sub>RMS</sub> , G = +1, f = 1 kHz, R <sub>L</sub> = 10 kΩ	0.001%						
<b>OUTPUT</b>									
V <sub>O</sub>	Voltage output swing from supply rails	V <sub>S</sub> = 1.8 V, R <sub>L</sub> = 10 kΩ	5	15					mV
		V <sub>S</sub> = 5.5 V, R <sub>L</sub> = 10 kΩ	5	20					mV
		V <sub>S</sub> = 1.8 V, R <sub>L</sub> = 2 kΩ	15	30					mV
		V <sub>S</sub> = 5.5 V, R <sub>L</sub> = 2 kΩ	22	40					mV
Over temperature		V <sub>S</sub> = 5.5 V, R <sub>L</sub> = 10 kΩ				30		mV	
		V <sub>S</sub> = 5.5 V, R <sub>L</sub> = 2 kΩ				60		mV	
I <sub>SC</sub>	Short-circuit current	V <sub>S</sub> = 5 V	±20						mA
R <sub>O</sub>	Open-loop output impedance	V <sub>S</sub> = 5.5 V, f = 100 Hz	570						Ω
<b>POWER SUPPLY</b>									
V <sub>S</sub>	Specified voltage range		1.8	5.5					V
I <sub>Q</sub>	Quiescent current per amplifier	OPA314, OPA2314, OPA4314, V <sub>S</sub> = 1.8 V, I <sub>O</sub> = 0 mA	130	180					μA
		OPA2314, OPA4314, V <sub>S</sub> = 5 V, I <sub>O</sub> = 0 mA	150	190					μA
		OPA314, V <sub>S</sub> = 5 V, I <sub>O</sub> = 0 mA	150	210					μA
Over temperature		V <sub>S</sub> = 5 V, I <sub>O</sub> = 0 mA				220		μA	
Power-on time		V <sub>S</sub> = 0 V to 5 V, to 90% I <sub>Q</sub> level	44						μs
<b>TEMPERATURE</b>									
Specified range			–40	125					°C
Operating range			–40	150					°C

(3) Signifies the slower value of the positive or negative slew rate.

(4) Third-order filter; bandwidth = 80 kHz at –3 dB.

## Electrical Characteristics (continued)

$V_S = 1.8\text{ V to }5.5\text{ V}$ ; At  $T_A = 25\text{ }^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	$T_A = 25\text{ }^\circ\text{C}$			$T_A = -40\text{ }^\circ\text{C to }125\text{ }^\circ\text{C}$			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
Storage range		-65		150				$^\circ\text{C}$

## 6.8 Typical Characteristics

**Table 1. Characteristic Performance Measurements**

TITLE	FIGURE
Open-Loop Gain and Phase vs Frequency	<a href="#">Figure 1</a>
Open-Loop Gain vs Temperature	<a href="#">Figure 2</a>
Quiescent Current vs Supply Voltage	<a href="#">Figure 3</a>
Quiescent Current vs Temperature	<a href="#">Figure 4</a>
Offset Voltage Production Distribution	<a href="#">Figure 5</a>
Offset Voltage Drift Distribution	<a href="#">Figure 6</a>
Offset Voltage vs Common-Mode Voltage (Maximum Supply)	<a href="#">Figure 7</a>
Offset Voltage vs Temperature	<a href="#">Figure 8</a>
CMRR and PSRR vs Frequency (RTI)	<a href="#">Figure 9</a>
CMRR and PSRR vs Temperature	<a href="#">Figure 10</a>
0.1-Hz to 10-Hz Input Voltage Noise (5.5 V)	<a href="#">Figure 11</a>
Input Voltage Noise Spectral Density vs Frequency (1.8 V, 5.5 V)	<a href="#">Figure 12</a>
Input Voltage Noise vs Common-Mode Voltage (5.5 V)	<a href="#">Figure 13</a>
Input Bias and Offset Current vs Temperature	<a href="#">Figure 14</a>
Open-Loop Output Impedance vs Frequency	<a href="#">Figure 15</a>
Maximum Output Voltage vs Frequency and Supply Voltage	<a href="#">Figure 16</a>
Output Voltage Swing vs Output Current (over Temperature)	<a href="#">Figure 17</a>
Closed-Loop Gain vs Frequency, $G = 1, -1, 10$ (1.8 V)	<a href="#">Figure 18</a>
Closed-Loop Gain vs Frequency, $G = 1, -1, 10$ (5.5 V)	<a href="#">Figure 19</a>
Small-Signal Overshoot vs Load Capacitance	<a href="#">Figure 20</a>
Small-Signal Step Response, Noninverting (1.8 V)	<a href="#">Figure 21</a>
Small-Signal Step Response, Noninverting ( 5.5 V)	<a href="#">Figure 22</a>
Large-Signal Step Response, Noninverting (1.8 V)	<a href="#">Figure 23</a>
Large-Signal Step Response, Noninverting ( 5.5 V)	<a href="#">Figure 24</a>
Positive Overload Recovery	<a href="#">Figure 25</a>
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No Phase Reversal	<a href="#">Figure 27</a>
Channel Separation vs Frequency (Dual)	<a href="#">Figure 28</a>
THD+N vs Amplitude ( $G = 1, 2\text{ k}\Omega, 10\text{ k}\Omega$ )	<a href="#">Figure 29</a>
THD+N vs Amplitude ( $G = -1, 2\text{ k}\Omega, 10\text{ k}\Omega$ )	<a href="#">Figure 30</a>
THD+N vs Frequency ( $0.5\text{ V}_{RMS}, G = +1, 2\text{ k}\Omega, 10\text{ k}\Omega$ )	<a href="#">Figure 31</a>
EMIRR	<a href="#">Figure 32</a>

OPA314, OPA2314, OPA4314

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At  $T_A = 25^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_{S/2}$ ,  $V_{CM} = V_{S/2}$ , and  $V_{OUT} = V_{S/2}$ , unless otherwise noted.

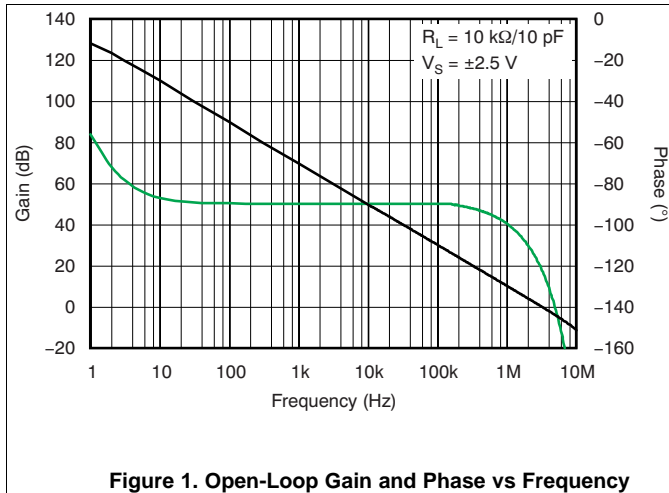


Figure 1. Open-Loop Gain and Phase vs Frequency

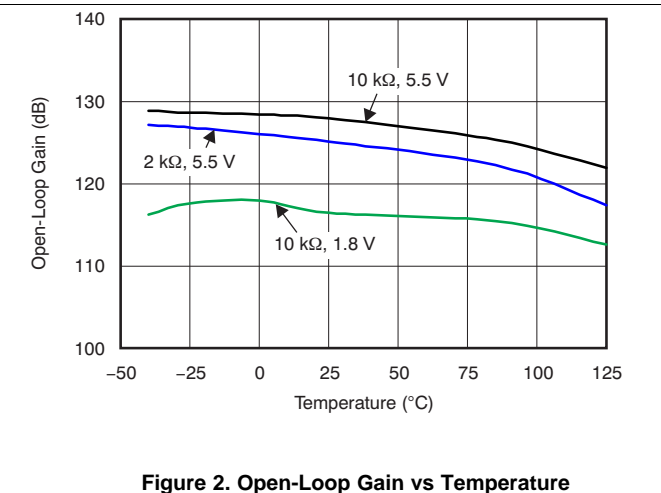


Figure 2. Open-Loop Gain vs Temperature

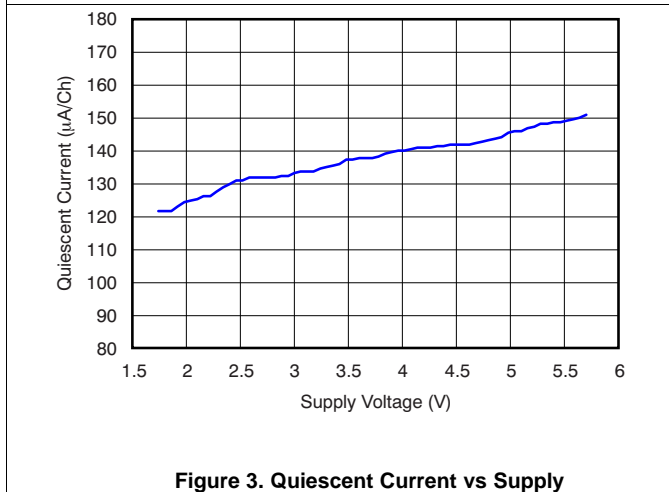


Figure 3. Quiescent Current vs Supply

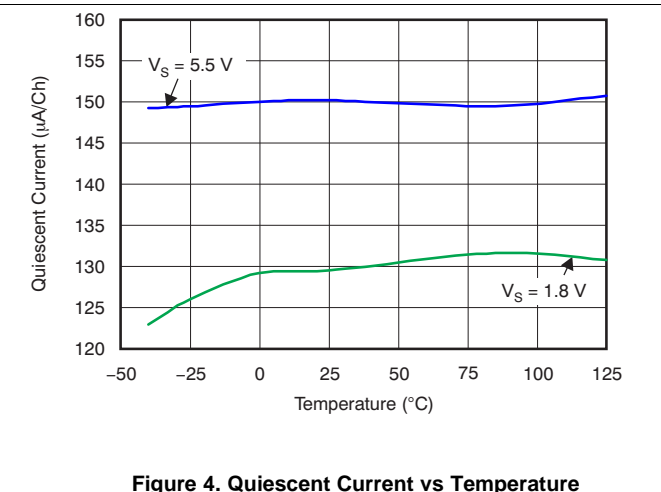


Figure 4. Quiescent Current vs Temperature

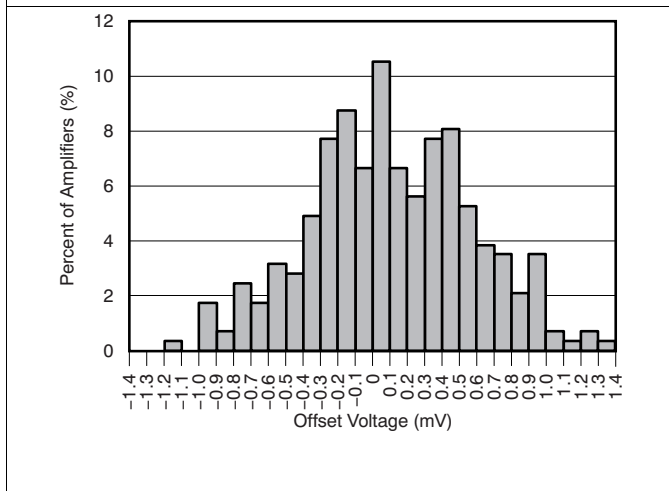


Figure 5. Offset Voltage Production Distribution

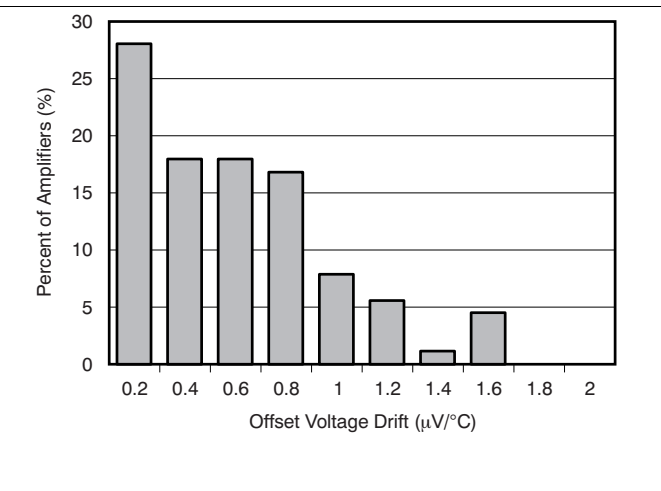


Figure 6. Offset Voltage Drift Distribution

At  $T_A = 25^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.

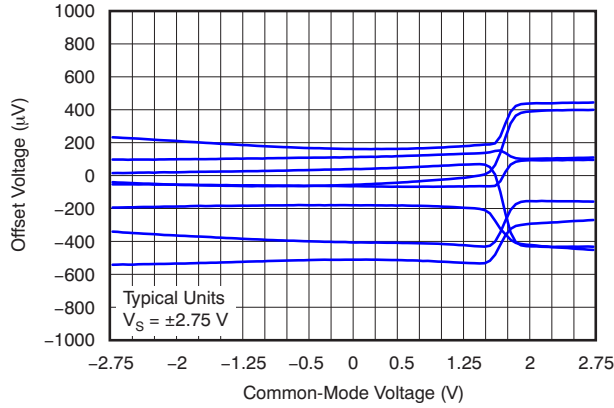


Figure 7. Offset Voltage vs Common-Mode Voltage

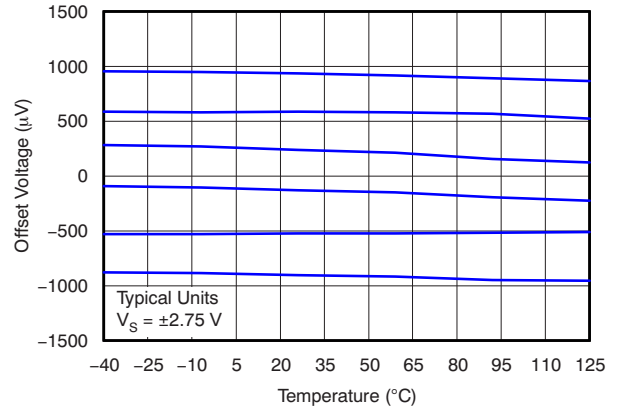


Figure 8. Offset Voltage vs Temperature

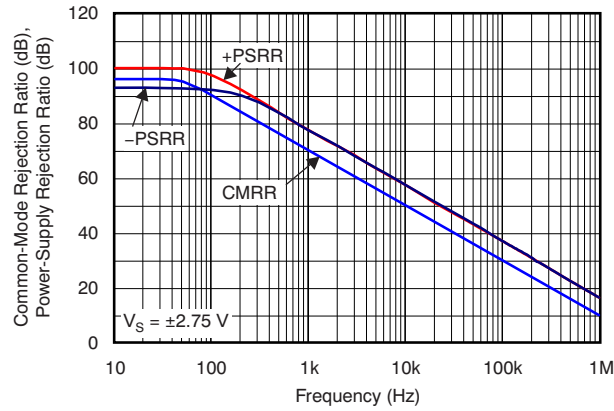


Figure 9. CMRR and PSRR vs Frequency (Referred-to-Input)

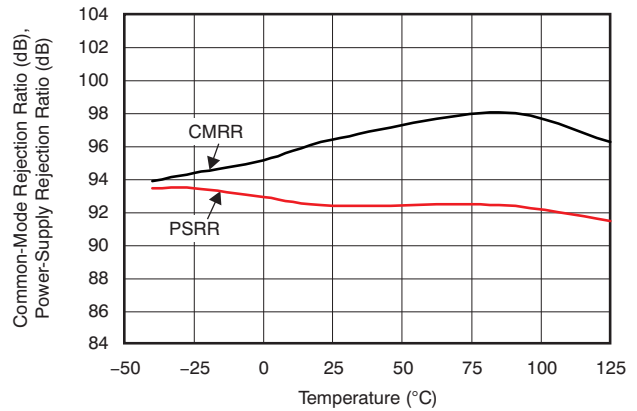


Figure 10. CMRR and PSRR vs Temperature

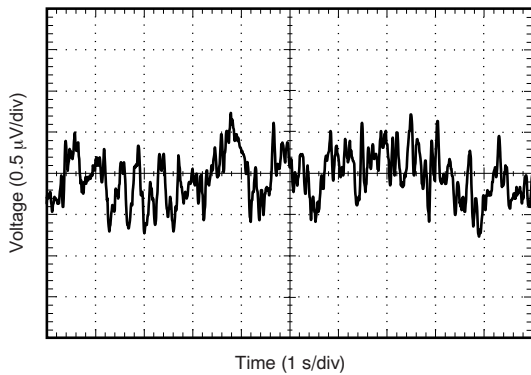


Figure 11. 0.1-Hz to 10-Hz Input Voltage Noise

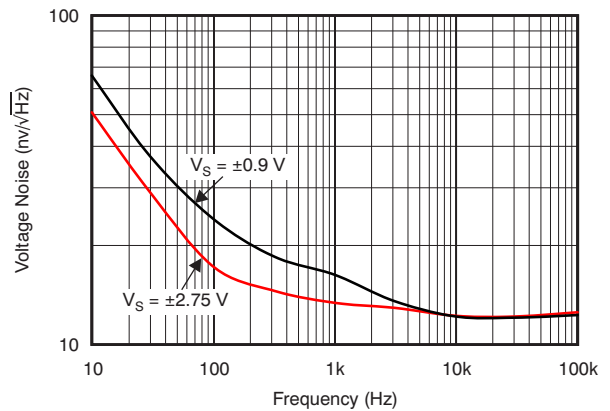


Figure 12. Input Voltage Noise Spectral Density vs Frequency

At  $T_A = 25^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.

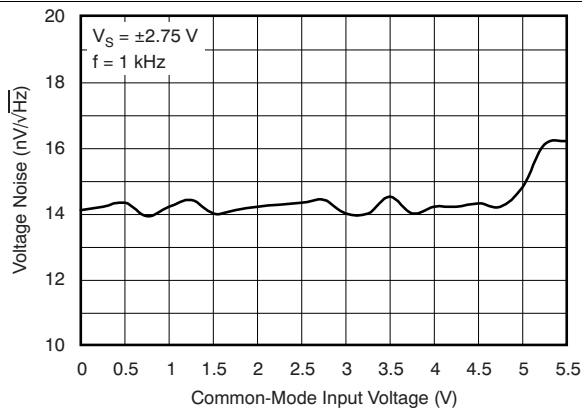


Figure 13. Voltage Noise vs Common-Mode Voltage

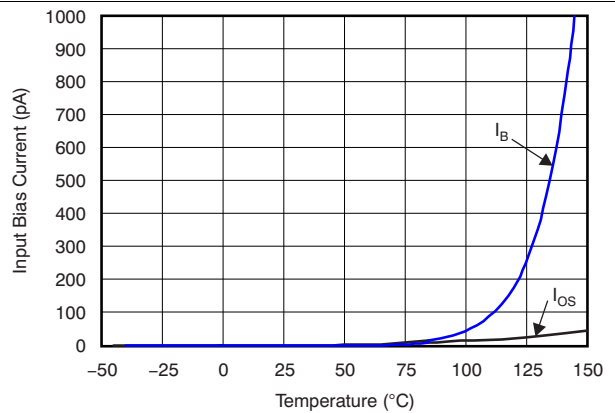


Figure 14. Input Bias and Offset Current vs Temperature

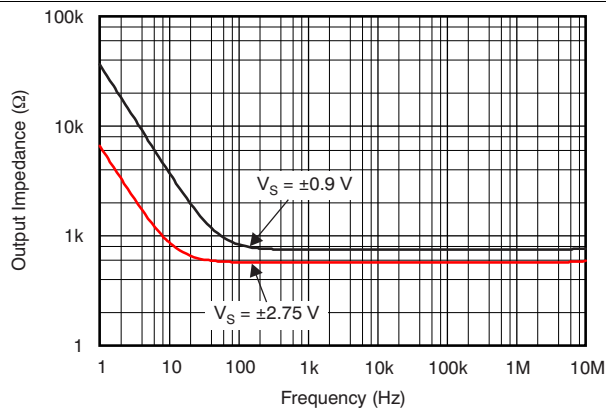


Figure 15. Open-Loop Output Impedance vs Frequency

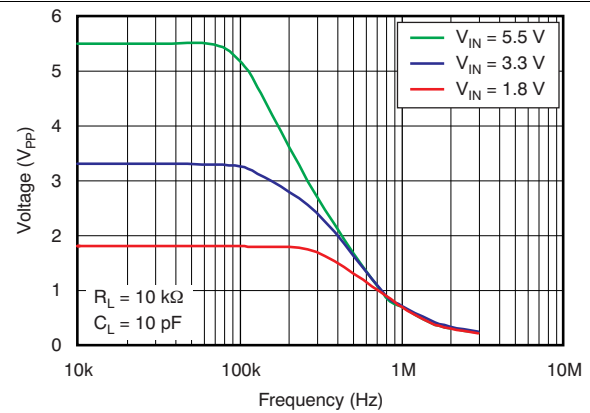


Figure 16. Maximum Output Voltage vs Frequency and Supply Voltage

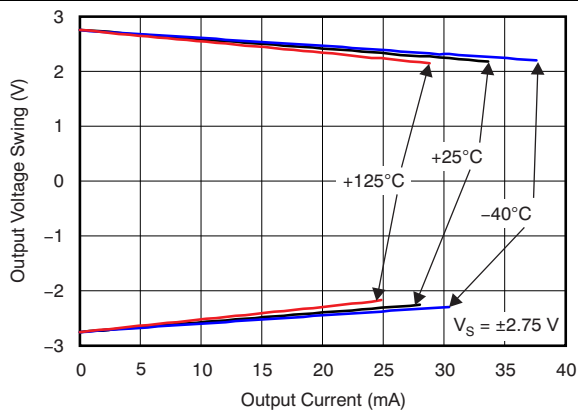


Figure 17. Output Voltage Swing vs Output Current (Over Temperature)

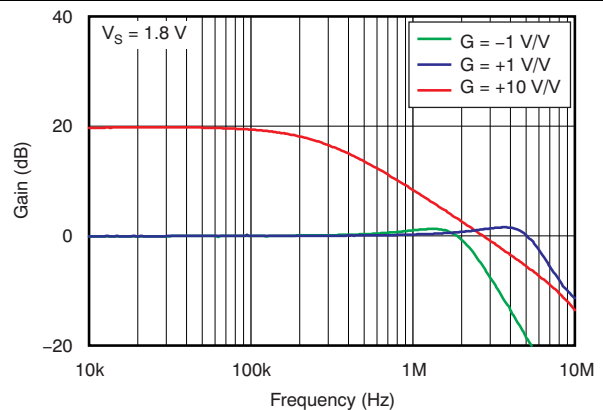


Figure 18. Closed-Loop Gain vs Frequency

At  $T_A = 25^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.

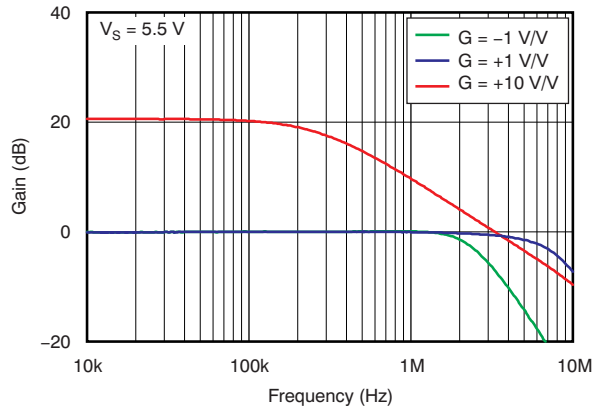


Figure 19. Closed-Loop Gain vs Frequency

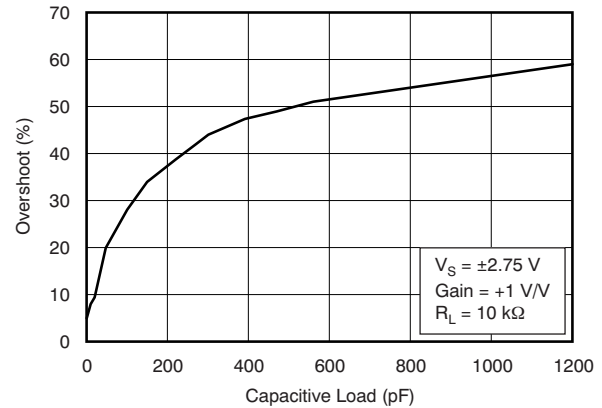


Figure 20. Small-Signal Overshoot vs Load Capacitance

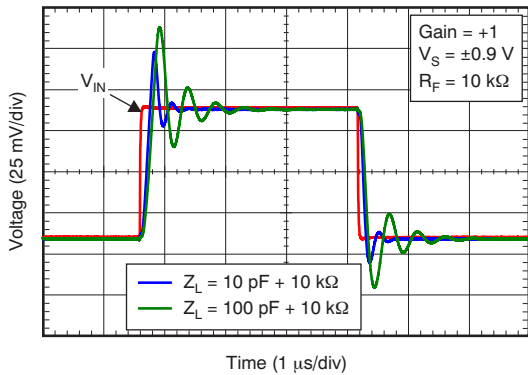


Figure 21. Small-Signal Pulse Response (Noninverting)

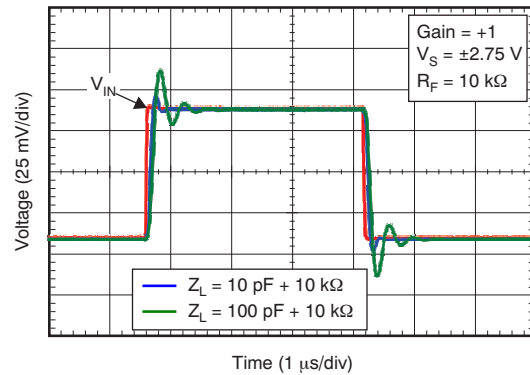


Figure 22. Small-Signal Pulse Response (Inverting)

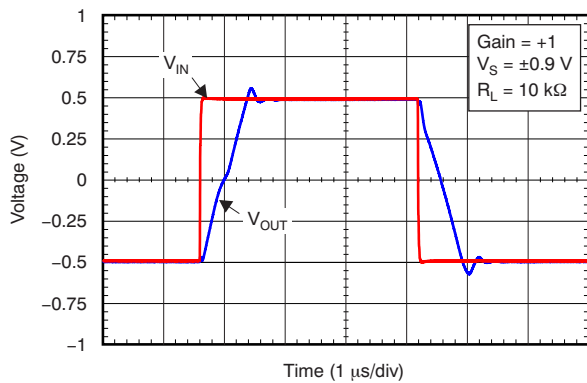


Figure 23. Large-Signal Pulse Response (Noninverting)

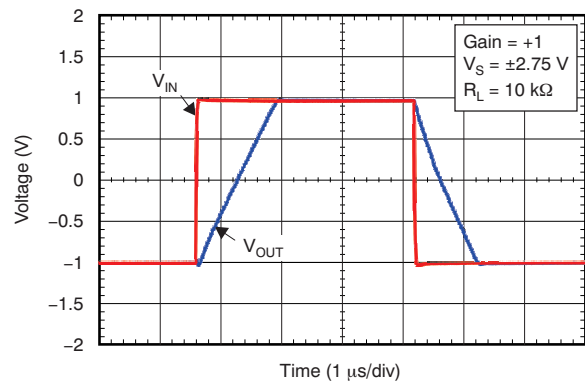
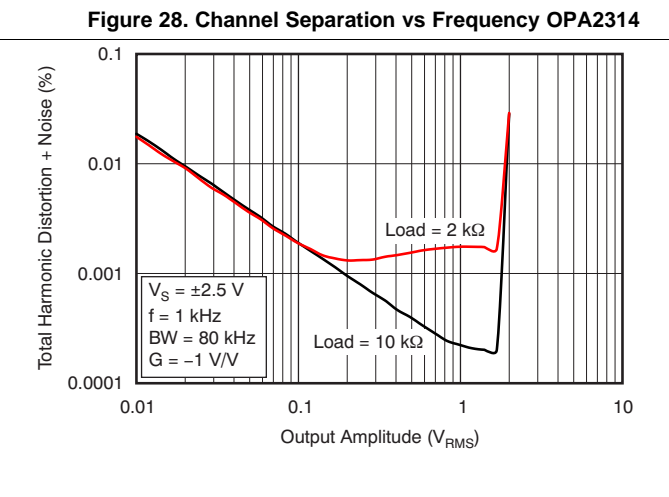
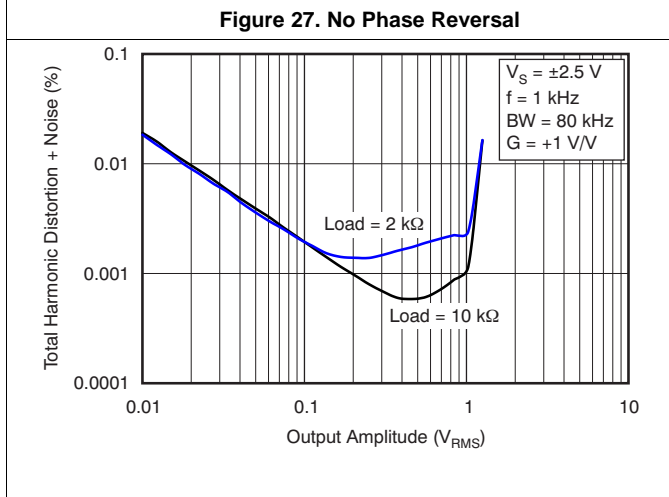
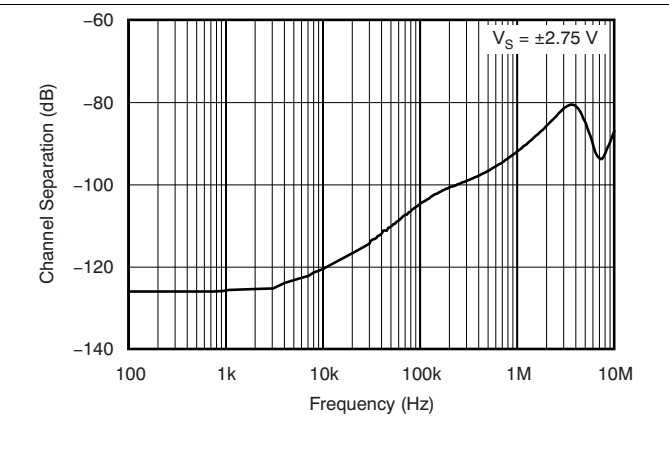
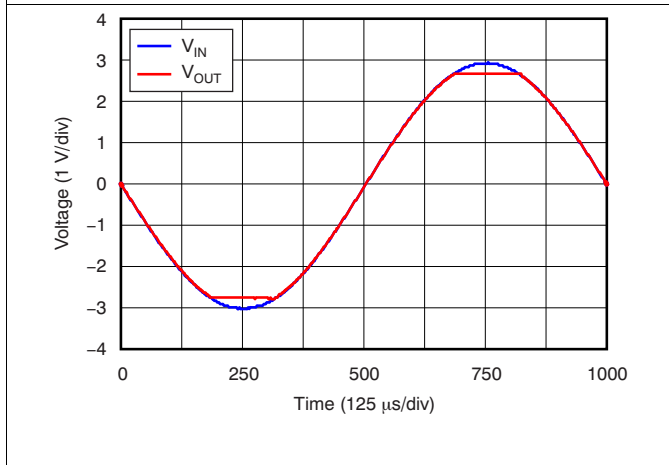
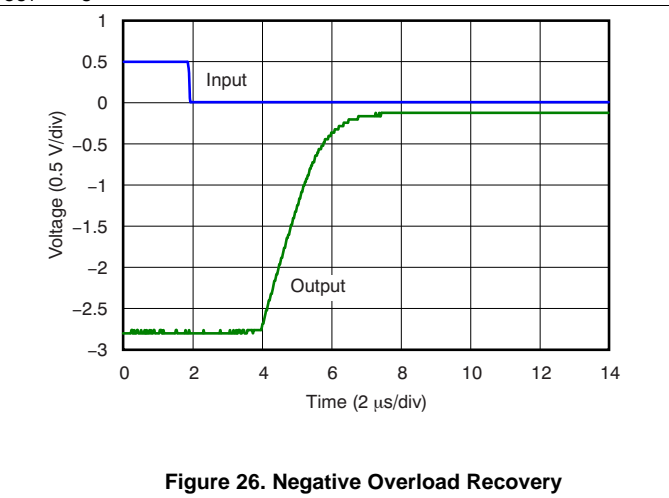
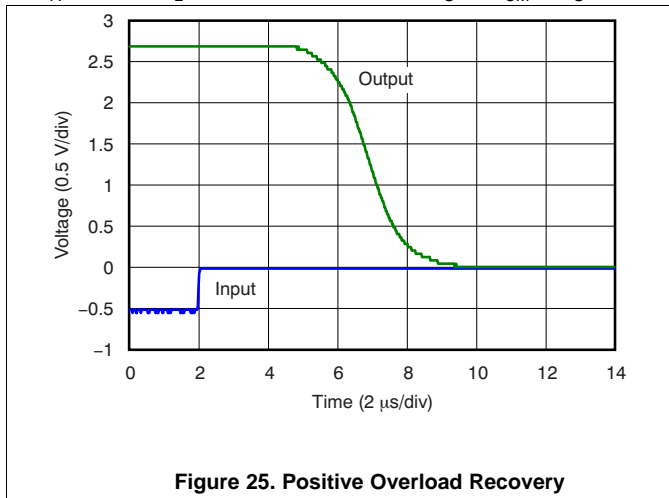
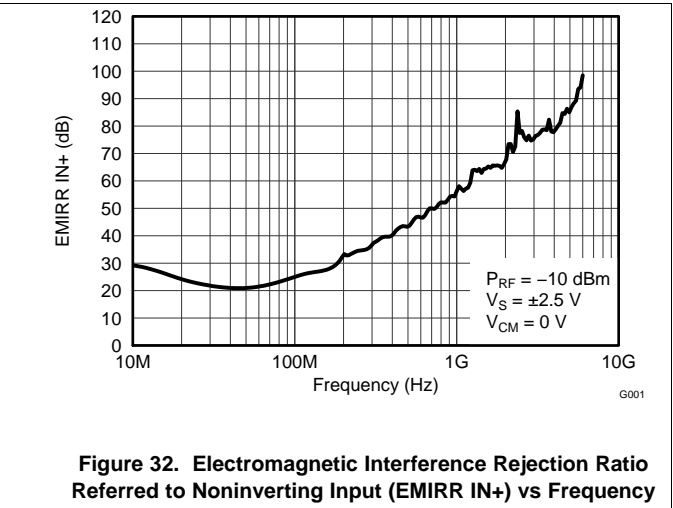
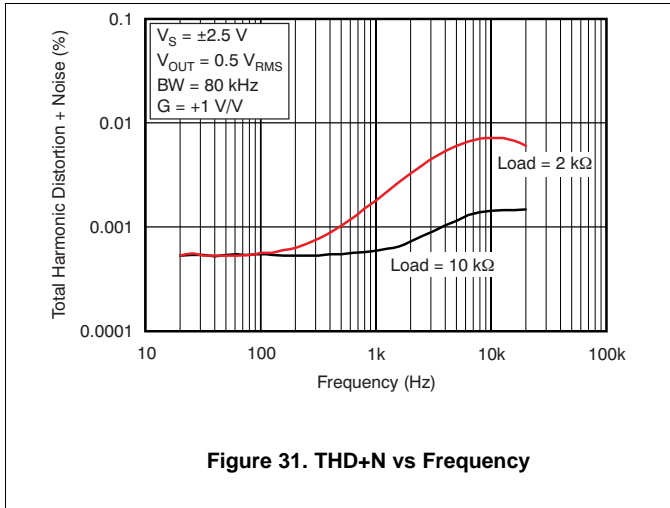


Figure 24. Large-Signal Pulse Response (Inverting)

At  $T_A = 25^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.



At  $T_A = 25^\circ\text{C}$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S/2$ ,  $V_{CM} = V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.



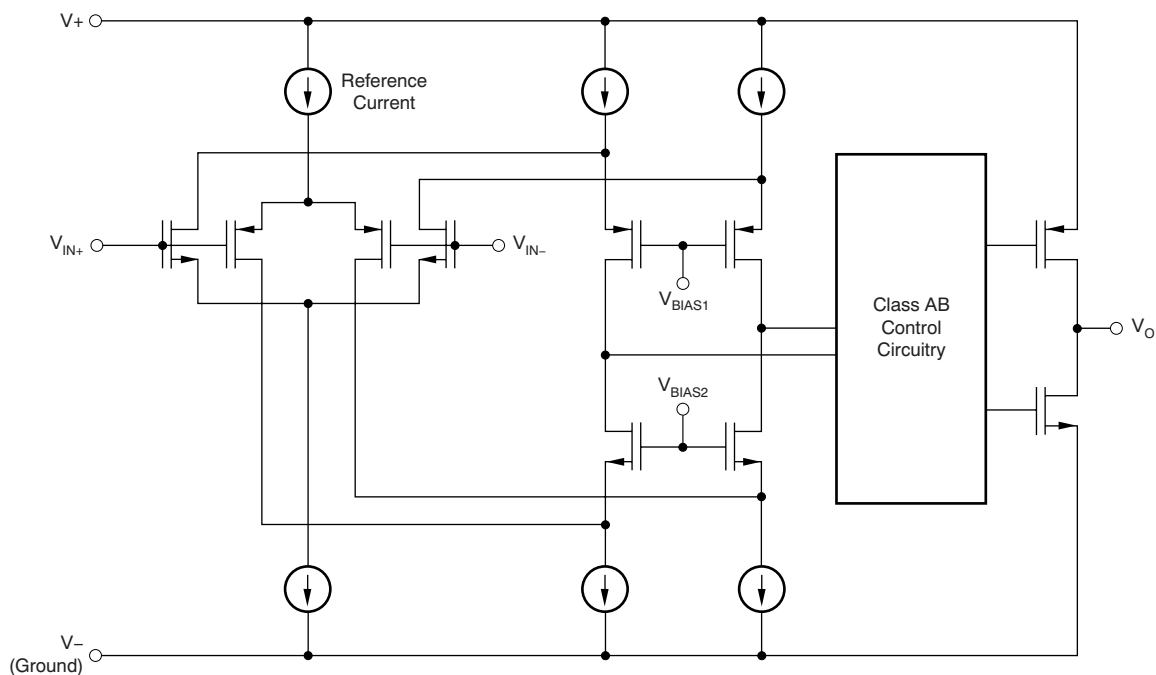
## 7 Detailed Description

### 7.1 Overview

The OPA314 is a family of low-power, rail-to-rail input and output operational amplifiers specifically designed for portable applications. These devices operate from 1.8 V to 5.5 V, are unity-gain stable, and suitable for a wide range of general-purpose applications. The class AB output stage is capable of driving  $\leq 10\text{-k}\Omega$  loads connected to any point between  $V+$  and ground. The input common-mode voltage range includes both rails, and allows the OPA314 series to be used in virtually any single-supply application. Rail-to-rail input and output swing significantly increases dynamic range, especially in low-supply applications, and makes them ideal for driving sampling analog-to-digital converters (ADCs).

The OPA314 features 3-MHz bandwidth and  $1.5\text{-V}/\mu\text{s}$  slew rate with only  $150\text{-}\mu\text{A}$  supply current per channel, providing good AC performance at very low power consumption. DC applications are also well served with a very low input noise voltage of  $14\text{ nV}/\sqrt{\text{Hz}}$  at 1 kHz, low input bias current ( $0.2\text{ pA}$ ), and an input offset voltage of  $0.5\text{ mV}$  (typical).

### 7.2 Functional Block Diagram



### 7.3 Feature Description

#### 7.3.1 Operating Voltage

The OPA314 series operational amplifiers are fully specified and ensured for operation from 1.8 V to 5.5 V. In addition, many specifications apply from  $-40^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . Parameters that vary significantly with operating voltages or temperature are shown in the *Typical Characteristics* graphs. Power-supply pins should be bypassed with  $0.01\text{-}\mu\text{F}$  ceramic capacitors.

## Feature Description (continued)

### 7.3.2 Rail-to-Rail Input

The input common-mode voltage range of the OPA314 series extends 200 mV beyond the supply rails. This performance is achieved with a complementary input stage: an N-channel input differential pair in parallel with a P-channel differential pair, as shown in Figure 33. The N-channel pair is active for input voltages close to the positive rail, typically  $(V+) - 1.3\text{ V}$  to 200 mV above the positive supply, while the P-channel pair is on for inputs from 200 mV below the negative supply to approximately  $(V+) - 1.3\text{ V}$ . There is a small transition region, typically  $(V+) - 1.4\text{ V}$  to  $(V+) - 1.2\text{ V}$ , in which both pairs are on. This 200-mV transition region can vary up to 300 mV with process variation. Thus, the transition region (both stages on) can range from  $(V+) - 1.7\text{ V}$  to  $(V+) - 1.5\text{ V}$  on the low end, up to  $(V+) - 1.1\text{ V}$  to  $(V+) - 0.9\text{ V}$  on the high end. Within this transition region, PSRR, CMRR, offset voltage, offset drift, and THD may be degraded compared to device operation outside this region.

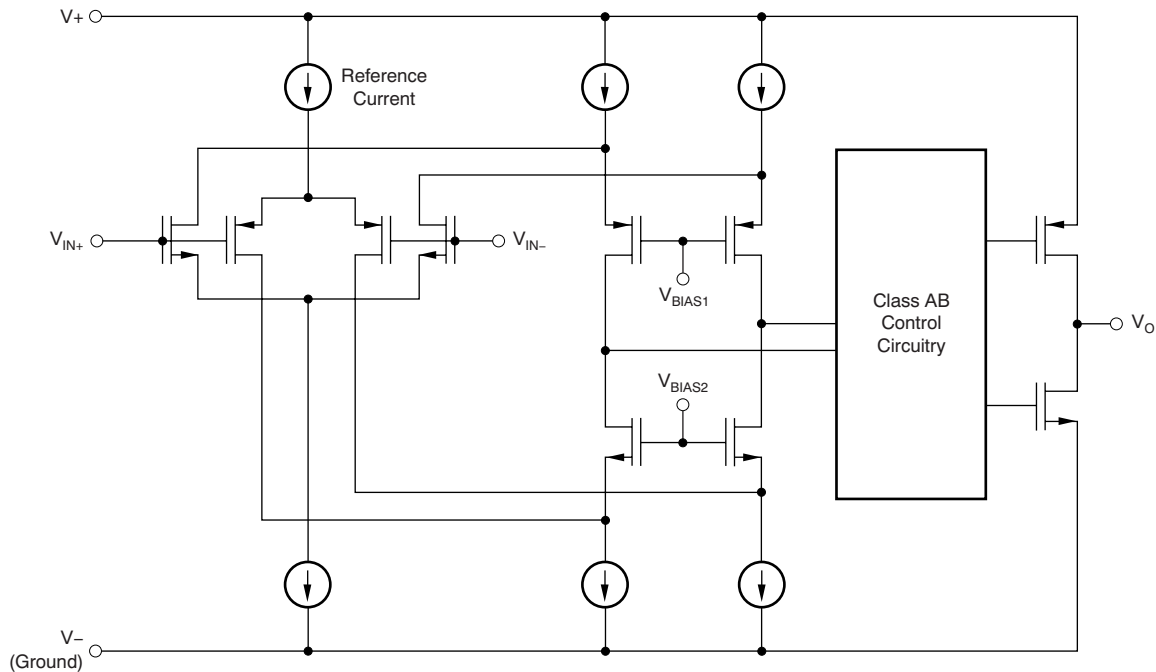


Figure 33. Simplified Schematic

### 7.3.3 Input and ESD Protection

The OPA314 family incorporates internal electrostatic discharge (ESD) protection circuits on all pins. In the case of input and output pins, this protection primarily consists of current-steering diodes connected between the input and power-supply pins. These ESD protection diodes also provide in-circuit, input overdrive protection, as long as the current is limited to 10 mA as stated in the *Absolute Maximum Ratings*. Figure 34 shows how a series input resistor may be added to the driven input to limit the input current. The added resistor contributes thermal noise at the amplifier input and its value should be kept to a minimum in noise-sensitive applications.

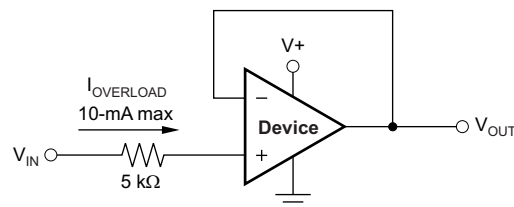


Figure 34. Input Current Protection

## Feature Description (continued)

### 7.3.4 Common-Mode Rejection Ratio (CMRR)

CMRR for the OPA314 is specified in several ways so the best match for a given application may be used; see the [Electrical Characteristics](#). First, the CMRR of the device in the common-mode range below the transition region [ $V_{CM} < (V+) - 1.3\text{ V}$ ] is given. This specification is the best indicator of the capability of the device when the application requires use of one of the differential input pairs. Second, the CMRR over the entire common-mode range is specified at ( $V_{CM} = -0.2\text{ V}$  to  $5.7\text{ V}$ ). This last value includes the variations seen through the transition region (see [Figure 7](#)).

### 7.3.5 EMI Susceptibility and Input Filtering

Operational amplifiers vary with regard to the susceptibility of the device to electromagnetic interference (EMI). If conducted EMI enters the operational amplifier, the DC offset observed at the amplifier output may shift from its nominal value while EMI is present. This shift is a result of signal rectification associated with the internal semiconductor junctions. While all operational amplifier pin functions can be affected by EMI, the signal input pins are likely to be the most susceptible. The OPA314 operational amplifier family incorporate an internal input low-pass filter that reduces the amplifiers response to EMI. Both common-mode and differential mode filtering are provided by this filter. The filter is designed for a cutoff frequency of approximately 80 MHz ( $-3\text{ dB}$ ), with a roll-off of 20 dB per decade.

Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. The EMI rejection ratio (EMIRR) metric allows operational amplifiers to be directly compared by the EMI immunity. [Figure 32](#) illustrates the results of this testing on the OPAX314. Detailed information can also be found in the application report, *EMI Rejection Ratio of Operational Amplifiers* ([SBOA128](#)), available for download from [www.ti.com](http://www.ti.com).

### 7.3.6 Rail-to-Rail Output

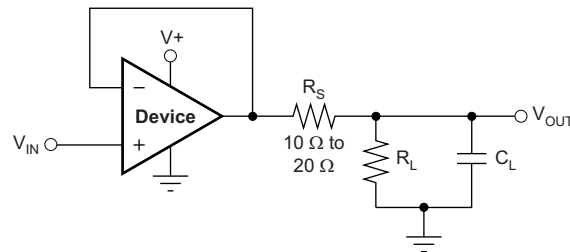
Designed as a micro-power, low-noise operational amplifier, the OPA314 delivers a robust output drive capability. A class AB output stage with common-source transistors is used to achieve full rail-to-rail output swing capability. For resistive loads up to 10 k $\Omega$ , the output swings typically to within 5 mV of either supply rail regardless of the power-supply voltage applied. Different load conditions change the ability of the amplifier to swing close to the rails; refer to [Figure 17](#).

### 7.3.7 Capacitive Load and Stability

The OPA314 is designed to be used in applications where driving a capacitive load is required. As with all operational amplifiers, there may be specific instances where the OPA314 can become unstable. The particular operational amplifiers circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether or not an amplifier is stable in operation. An operational amplifier in the unity-gain ( $+1\text{-V/V}$ ) buffer configuration that drives a capacitive load exhibits a greater tendency to be unstable than an amplifier operated at a higher noise gain. The capacitive load, in conjunction with the operational amplifier output resistance, creates a pole within the feedback loop that degrades the phase margin. The degradation of the phase margin increases as the capacitive loading increases. When operating in the unity-gain configuration, the OPA314 remains stable with a pure capacitive load up to approximately 1 nF. The equivalent series resistance (ESR) of some very large capacitors ( $C_L$  greater than 1  $\mu\text{F}$ ) is sufficient to alter the phase characteristics in the feedback loop such that the amplifier remains stable. Increasing the amplifier closed-loop gain allows the amplifier to drive increasingly larger capacitance. This increased capability is evident when observing the overshoot response of the amplifier at higher voltage gains. See [Figure 20](#).

One technique for increasing the capacitive load drive capability of the amplifier operating in a unity-gain configuration is to insert a small resistor, typically 10  $\Omega$  to 20  $\Omega$ , in series with the output, as shown in [Figure 35](#). This resistor significantly reduces the overshoot and ringing associated with large capacitive loads. One possible problem with this technique, however, is that a voltage divider is created with the added series resistor and any resistor connected in parallel with the capacitive load. The voltage divider introduces a gain error at the output that reduces the output swing.

**Feature Description (continued)**



**Figure 35. Improving Capacitive Load Drive**

**7.4 Device Functional Modes**

The OPA2314 device is powered on when the supply is connected. The device can be operated as a single-supply operational amplifier or a dual-supply amplifier, depending on the application.

## 8 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

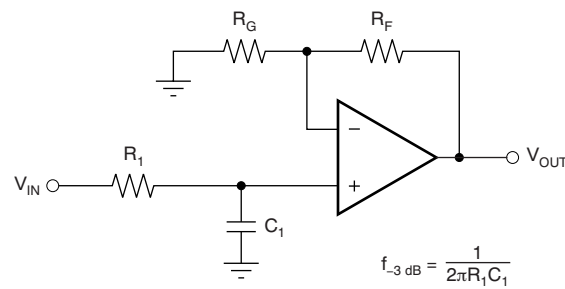
### 8.1 Application Information

The OPA2314 device is a low-power, rail-to-rail input and output operational amplifier specifically designed for portable applications. The device operates from 1.8 V to 5.5 V, is unity-gain stable, and suitable for a wide range of general-purpose applications. The class AB output stage is capable of driving  $\leq 10\text{-k}\Omega$  loads connected to any point between  $V+$  and ground. The input common-mode voltage range includes both rails, and allows the OPA2314 device to be used in virtually any single-supply application. Rail-to-rail input and output swing significantly increases dynamic range, especially in low-supply applications, and makes the device ideal for driving sampling analog-to-digital converters (ADCs).

The OPA2314 device features a 3-MHz bandwidth and 1.5-V/ $\mu\text{s}$  slew rate with only 150- $\mu\text{A}$  supply current per channel, providing good AC performance at very low power consumption. DC applications are also well served with a very-low input noise voltage of 14 nV/ $\sqrt{\text{Hz}}$  at 1 kHz, low-input bias current (0.2 pA), and an input offset voltage of 0.5 mV (typical).

#### 8.1.1 General Configurations

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. The simplest way to establish this limited bandwidth is to place an RC filter at the noninverting terminal of the amplifier, as [Figure 36](#) shows.



$$\frac{V_{\text{OUT}}}{V_{\text{IN}}} = \left(1 + \frac{R_F}{R_G}\right) \left(\frac{1}{1 + sR_1C_1}\right)$$

**Figure 36. Single-Pole Low-Pass Filter**

If even more attenuation is needed, a multiple pole filter is required. The Sallen-Key filter can be used for this task, as [Figure 37](#) shows. For best results, the amplifier should have a bandwidth that is eight to 10 times the filter frequency bandwidth. Failure to follow this guideline can result in phase shift of the amplifier.

Application Information (continued)

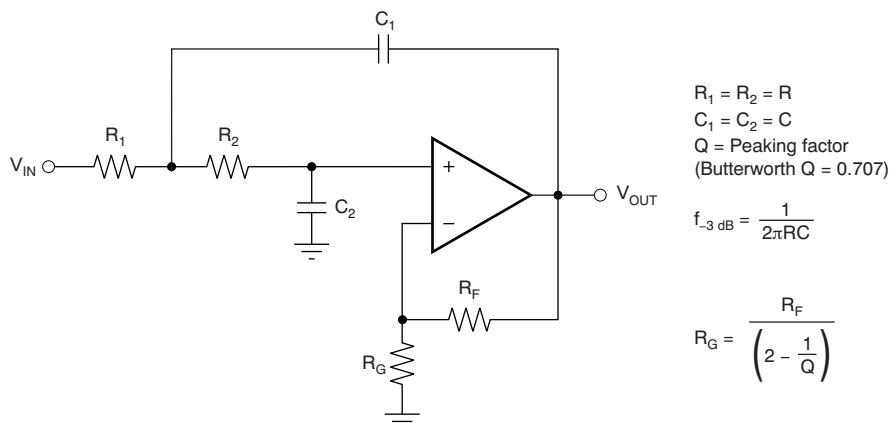


Figure 37. Two-Pole Low-Pass Sallen-Key Filter

8.1.2 Capacitive Load and Stability

The OPA2314 device is designed to be used in applications where driving a capacitive load is required. As with all op-amps, specific instances can occur where the OPA2314 device can become unstable. The particular op-amp circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether or not an amplifier is stable in operation. An op-amp in the unity-gain (1 V/V) buffer configuration that drives a capacitive load exhibits a greater tendency to be unstable than an amplifier operated at a higher noise gain. The capacitive load, in conjunction with the op-amp output resistance, creates a pole within the feedback loop that degrades the phase margin. The degradation of the phase margin increases as the capacitive loading increases. When operating in the unity-gain configuration, the OPA2314 device remains stable with a pure capacitive load up to approximately 1 nF. The equivalent series resistance (ESR) of some very large capacitors ( $C_L$  greater than 1  $\mu\text{F}$ ) is sufficient to alter the phase characteristics in the feedback loop such that the amplifier remains stable. Increasing the amplifier closed-loop gain allows the amplifier to drive increasingly larger capacitance. This increased capability is evident when observing the overshoot response of the amplifier at higher voltage gains. See the graph, [Figure 20](#).

One technique for increasing the capacitive load drive capability of the amplifier operating in a unity-gain configuration is to insert a small resistor, typically 10  $\Omega$  to 20  $\Omega$ , in series with the output, as shown in [Figure 38](#). This resistor significantly reduces the overshoot and ringing associated with large capacitive loads. One possible problem with this technique, however, is that a voltage divider is created with the added series resistor and any resistor connected in parallel with the capacitive load. The voltage divider introduces a gain error at the output that reduces the output swing.

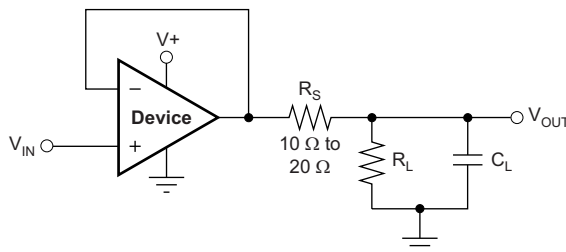
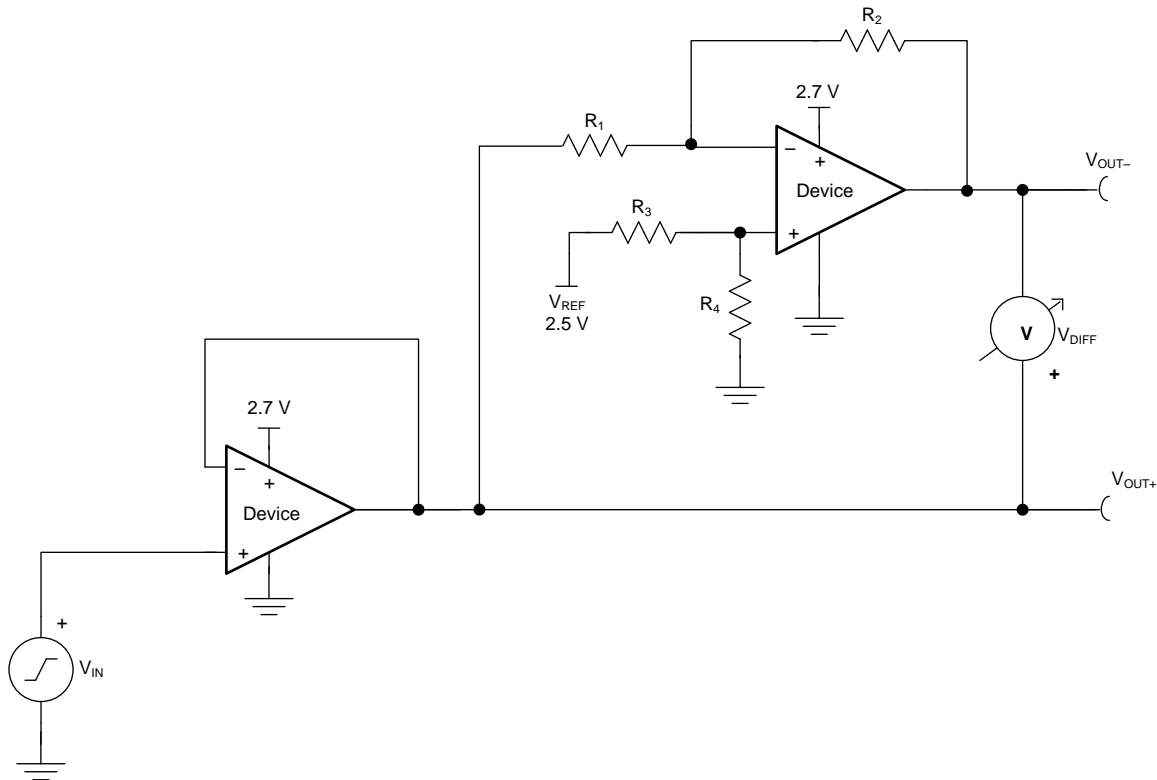


Figure 38. Improving Capacitive Load Drive

## 8.2 Typical Application

Some applications require differential signals. [Figure 39](#) shows a simple circuit to convert a single-ended input of 0.1 V to 2.4 V into a differential output of  $\pm 2.3$  V on a single 2.7-V supply. The output range is intentionally limited to maximize linearity. The circuit is composed of two amplifiers. One amplifier functions as a buffer and creates a voltage,  $V_{OUT+}$ . The second amplifier inverts the input and adds a reference voltage to generate  $V_{OUT-}$ . Both  $V_{OUT+}$  and  $V_{OUT-}$  range from 0.1 V to 2.4 V. The difference,  $V_{DIFF}$ , is the difference between  $V_{OUT+}$  and  $V_{OUT-}$ . This makes the differential output voltage range 2.3 V.



**Figure 39. Schematic for a Single-Ended Input to Differential Output Conversion**

### 8.2.1 Design Requirements

The design requirements are as follows:

- Supply voltage: 2.7 V
- Reference voltage: 2.5 V
- Input: 0.1 V to 2.4 V
- Output differential:  $\pm 2.3$  V
- Output common-mode voltage: 1.25 V
- Small-signal bandwidth: 1 MHz

### 8.2.2 Detailed Design Procedure

The circuit in [Figure 39](#) takes a single-ended input signal,  $V_{IN}$ , and generates two output signals,  $V_{OUT+}$  and  $V_{OUT-}$  using two amplifiers and a reference voltage,  $V_{REF}$ .  $V_{OUT+}$  is the output of the first amplifier and is a buffered version of the input signal,  $V_{IN}$  (as shown in [Equation 1](#)).  $V_{OUT-}$  is the output of the second amplifier which uses  $V_{REF}$  to add an offset voltage to  $V_{IN}$  and feedback to add inverting gain. The transfer function for  $V_{OUT-}$  is given in [Equation 2](#).

$$V_{OUT+} = V_{IN} \quad (1)$$

$$V_{OUT-} = V_{REF} \times \left( \frac{R_4}{R_3 + R_4} \right) \times \left( 1 + \frac{R_2}{R_1} \right) - V_{IN} \times \frac{R_2}{R_1} \quad (2)$$

### Typical Application (continued)

The differential output signal,  $V_{DIFF}$ , is the difference between the two single-ended output signals,  $V_{OUT+}$  and  $V_{OUT-}$ . Equation 3 shows the transfer function for  $V_{DIFF}$ . By applying the conditions that  $R_1 = R_2$  and  $R_3 = R_4$ , the transfer function is simplified into Equation 6. Using this configuration, the maximum input signal is equal to the reference voltage and the maximum output of each amplifier is equal to  $V_{REF}$ . The differential output range is  $2 \times V_{REF}$ . Furthermore, the common-mode voltage is one half of  $V_{REF}$  (see Equation 7).

$$V_{DIFF} = V_{OUT+} - V_{OUT-} = V_{IN} \times \left(1 + \frac{R_2}{R_1}\right) - V_{REF} \times \left(\frac{R_4}{R_3 + R_4}\right) \times \left(1 + \frac{R_2}{R_1}\right) \quad (3)$$

$$V_{OUT+} = V_{IN} \quad (4)$$

$$V_{OUT-} = V_{REF} - V_{IN} \quad (5)$$

$$V_{DIFF} = 2 \times V_{IN} - V_{REF} \quad (6)$$

$$V_{CM} = \left(\frac{V_{OUT+} + V_{OUT-}}{2}\right) = \frac{1}{2} V_{REF} \quad (7)$$

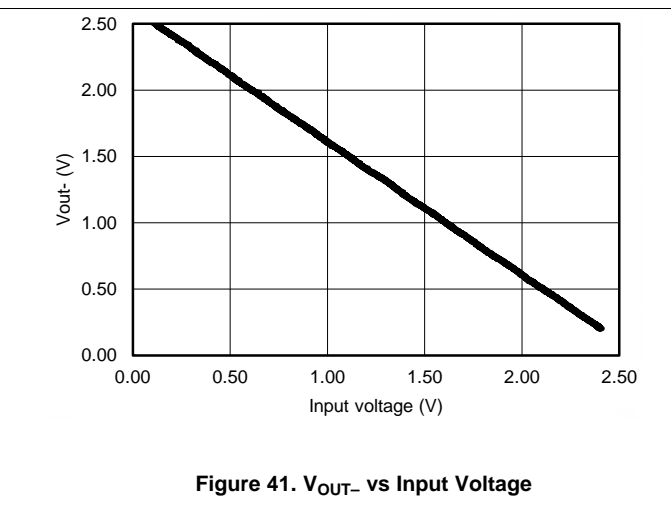
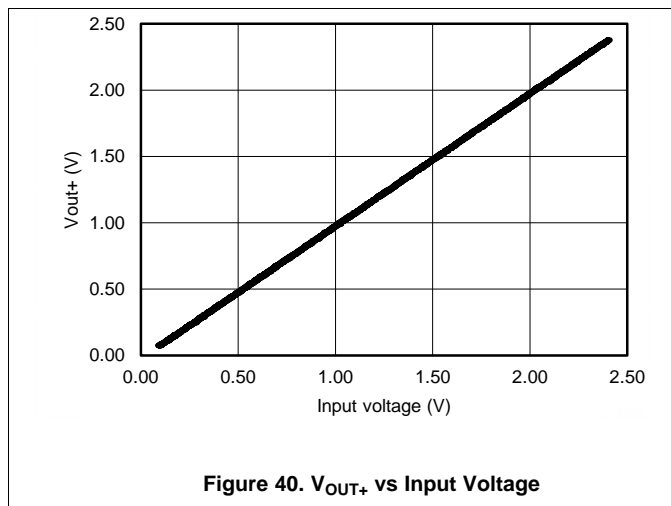
#### 8.2.2.1 Amplifier Selection

Linearity over the input range is key for good dc accuracy. The common-mode input range and output swing limitations determine the linearity. In general, an amplifier with rail-to-rail input and output swing is required. Bandwidth is a key concern for this design, so the OPA2314-Q1 device is selected because its bandwidth is greater than the target of 1 MHz. The bandwidth and power ratio makes this device power efficient and the low offset and drift ensure good accuracy for moderate precision applications.

#### 8.2.2.2 Passive Component Selection

Because the transfer function of  $V_{out-}$  is heavily reliant on resistors ( $R_1$ ,  $R_2$ ,  $R_3$ , and  $R_4$ ), use resistors with low tolerances to maximize performance and minimize error. This design uses resistors with resistance values of 49.9 k $\Omega$  and tolerances of 0.1%. However, if the noise of the system is a key parameter, smaller resistance values (6 k $\Omega$  or lower) can be selected to keep the overall system noise low. This ensures that the noise from the resistors is lower than the amplifier noise.

#### 8.2.3 Application Curves



## Typical Application (continued)

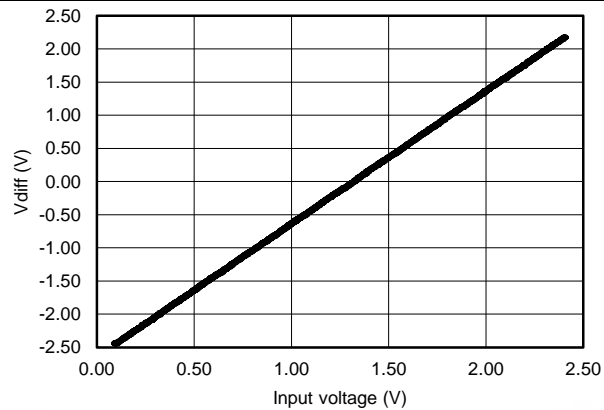


Figure 42. V<sub>DIFF</sub> vs Input Voltage

## 9 Power Supply Recommendations

The OPA2314-Q1 device is specified for operation from 1.8 V to 5.5 V ( $\pm 0.9$  V to  $\pm 2.75$  V); many specifications apply from  $-40^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The [Typical Characteristics](#) presents parameters that can exhibit significant variance with regard to operating voltage or temperature.

### CAUTION

Supply voltages larger than 7 V can permanently damage the device (see the [Absolute Maximum Ratings](#)).

Place 0.1- $\mu\text{F}$  bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, refer to the [Layout Guidelines](#) section.

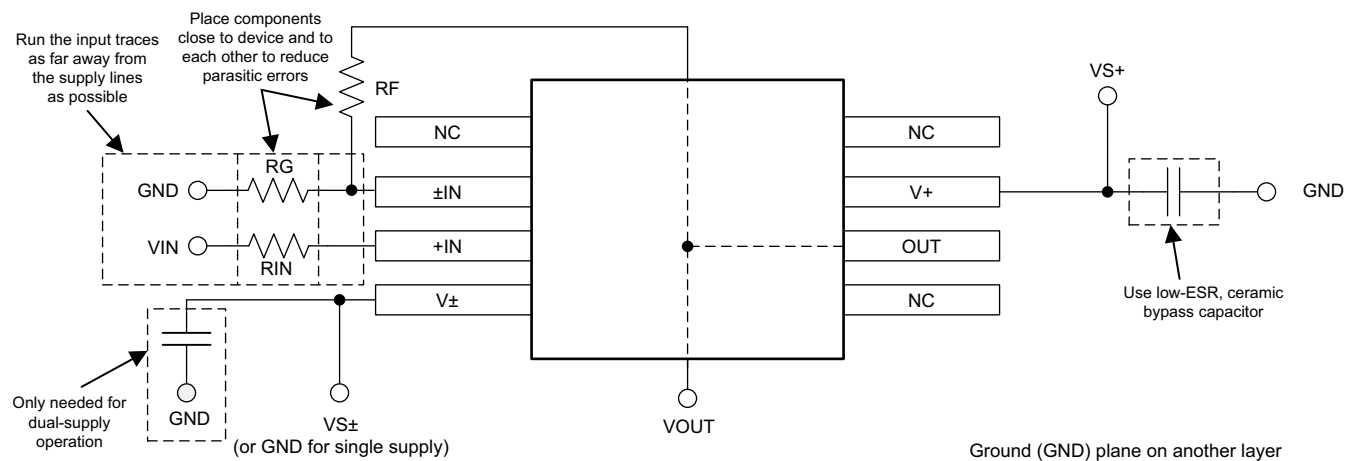
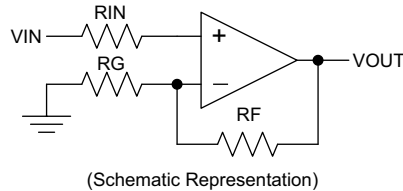
## 10 Layout

### 10.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and the operational amplifier. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
  - Connect low-ESR, 0.1- $\mu$ F ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for single-supply applications.
- Separate grounding for analog and digital portions of the circuitry is one of the simplest and most effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds, paying attention to the flow of the ground current. For more detailed information, refer to *Circuit Board Layout Techniques*, [SLOA089](#).
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicularly is much better than crossing in parallel with the noisy trace.
- Place the external components as close to the device as possible. Keeping RF and RG close to the inverting input minimizes parasitic capacitance, as shown in [Figure 43](#).
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.

### 10.2 Layout Example



**Figure 43. Operational Amplifier Board Layout for Noninverting Configuration**

## 11 Device and Documentation Support

### 11.1 Device Support

#### 11.1.1 Device Nomenclature

##### 11.1.1.1 DFN Package

The OPA2314 (dual version) uses the DFN style package (also known as SON); this package is a QFN with contacts on only two sides of the package bottom. This leadless package maximizes printed circuit board (PCB) space and offers enhanced thermal and electrical characteristics through an exposed pad. One of the primary advantages of the DFN package is its low, 0.9-mm height. DFN packages are physically small, have a smaller routing area, improved thermal performance, reduced electrical parasitics, and use a pinout scheme that is consistent with other commonly-used packages, such as SO and MSOP. Additionally, the absence of external leads eliminates bent-lead issues.

The DFN package can easily be mounted using standard PCB assembly techniques. See Application Note, *QFN/SON PCB Attachment (SLUA271)* and Application Report, *Quad Flatpack No-Lead Logic Packages (SCBA017)*, both available for download from [www.ti.com](http://www.ti.com).

#### NOTE

The exposed leadframe die pad on the bottom of the DFN package should be connected to the most negative potential (V-).

### 11.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 2. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
OPA314	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
OPA2314	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
OPA4314	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>

### 11.3 Community Resource

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 11.4 Trademarks

E2E is a trademark of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 11.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 11.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">OPA2314AID</a>	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
OPA2314AID.A	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
OPA2314AID.B	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
OPA2314AIDG4	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
OPA2314AIDG4.A	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
OPA2314AIDG4.B	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
<a href="#">OPA2314AIDGK</a>	Active	Production	VSSOP (DGK)   8	80   TUBE	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	OCPQ
OPA2314AIDGK.A	Active	Production	VSSOP (DGK)   8	80   TUBE	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	OCPQ
OPA2314AIDGK.B	Active	Production	VSSOP (DGK)   8	80   TUBE	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	OCPQ
<a href="#">OPA2314AIDGKR</a>	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU   SN   NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	OCPQ
OPA2314AIDGKR.A	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OCPQ
<a href="#">OPA2314AIDR</a>	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
OPA2314AIDR.A	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
OPA2314AIDR.B	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2314
<a href="#">OPA2314AIDRBR</a>	Active	Production	SON (DRB)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
OPA2314AIDRBR.A	Active	Production	SON (DRB)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
OPA2314AIDRBR.B	Active	Production	SON (DRB)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
<a href="#">OPA2314AIDRBT</a>	Active	Production	SON (DRB)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
OPA2314AIDRBT.A	Active	Production	SON (DRB)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
OPA2314AIDRBT.B	Active	Production	SON (DRB)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
OPA2314AIDRBTG4	Active	Production	SON (DRB)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
OPA2314AIDRBTG4.A	Active	Production	SON (DRB)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
OPA2314AIDRBTG4.B	Active	Production	SON (DRB)   8	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	QXY
<a href="#">OPA314AIDBVR</a>	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
OPA314AIDBVR.A	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
OPA314AIDBVR.B	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
OPA314AIDBVRG4	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
OPA314AIDBVRG4.A	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
OPA314AIDBVRG4.B	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
<a href="#">OPA314AIDBVT</a>	Active	Production	SOT-23 (DBV)   5	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
OPA314AIDBVT.A	Active	Production	SOT-23 (DBV)   5	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
OPA314AIDBVT.B	Active	Production	SOT-23 (DBV)   5	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	RAZ
<a href="#">OPA314AIDCKR</a>	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 125	SAA
OPA314AIDCKR.A	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	SAA
OPA314AIDCKR.B	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	SAA
OPA314AIDCKRG4	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	SAA
OPA314AIDCKRG4.A	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	SAA
OPA314AIDCKRG4.B	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	SAA
<a href="#">OPA314AIDCKT</a>	Active	Production	SC70 (DCK)   5	250   SMALL T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 125	SAA
OPA314AIDCKT.A	Active	Production	SC70 (DCK)   5	250   SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	SAA
OPA314AIDCKT.B	Active	Production	SC70 (DCK)   5	250   SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	SAA
<a href="#">OPA4314AIPW</a>	Active	Production	TSSOP (PW)   14	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4314
OPA4314AIPW.A	Active	Production	TSSOP (PW)   14	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4314
<a href="#">OPA4314AIPWR</a>	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4314
OPA4314AIPWR.A	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4314
OPA4314AIPWRG4	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4314
OPA4314AIPWRG4.A	Active	Production	TSSOP (PW)   14	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4314

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**OTHER QUALIFIED VERSIONS OF OPA2314, OPA314, OPA4314 :**

- Automotive : [OPA2314-Q1](#), [OPA314-Q1](#), [OPA4314-Q1](#)
- Enhanced Product : [OPA2314-EP](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product - Supports Defense, Aerospace and Medical Applications

**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**

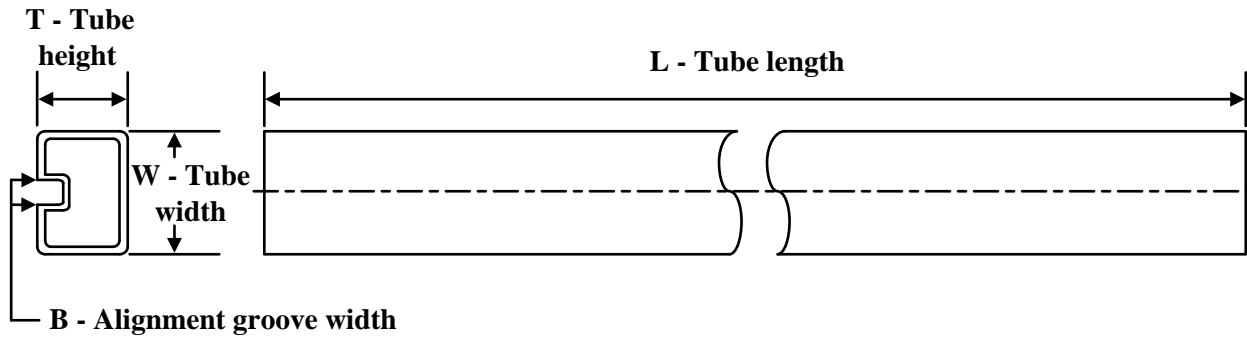

\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA2314AIDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2314AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA2314AIDRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA2314AIDRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA2314AIDRBTG4	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA314AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
OPA314AIDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
OPA314AIDBVRG4	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
OPA314AIDBVT	SOT-23	DBV	5	250	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
OPA314AIDCKR	SC70	DCK	5	3000	180.0	8.4	2.3	2.5	1.2	4.0	8.0	Q3
OPA314AIDCKR	SC70	DCK	5	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
OPA314AIDCKRG4	SC70	DCK	5	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
OPA314AIDCKT	SC70	DCK	5	250	180.0	8.4	2.3	2.5	1.2	4.0	8.0	Q3
OPA4314AIPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
OPA4314AIPWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA2314AIDGKR	VSSOP	DGK	8	2500	353.0	353.0	32.0
OPA2314AIDR	SOIC	D	8	2500	353.0	353.0	32.0
OPA2314AIDRBR	SON	DRB	8	3000	367.0	367.0	35.0
OPA2314AIDRBT	SON	DRB	8	250	210.0	185.0	35.0
OPA2314AIDRBTG4	SON	DRB	8	250	210.0	185.0	35.0
OPA314AIDBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
OPA314AIDBVR	SOT-23	DBV	5	3000	180.0	180.0	18.0
OPA314AIDBVRG4	SOT-23	DBV	5	3000	180.0	180.0	18.0
OPA314AIDBVT	SOT-23	DBV	5	250	180.0	180.0	18.0
OPA314AIDCKR	SC70	DCK	5	3000	210.0	185.0	35.0
OPA314AIDCKR	SC70	DCK	5	3000	180.0	180.0	18.0
OPA314AIDCKRG4	SC70	DCK	5	3000	180.0	180.0	18.0
OPA314AIDCKT	SC70	DCK	5	250	210.0	185.0	35.0
OPA4314AIPWR	TSSOP	PW	14	2000	353.0	353.0	32.0
OPA4314AIPWRG4	TSSOP	PW	14	2000	353.0	353.0	32.0

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
OPA2314AID	D	SOIC	8	75	506.6	8	3940	4.32
OPA2314AID.A	D	SOIC	8	75	506.6	8	3940	4.32
OPA2314AID.B	D	SOIC	8	75	506.6	8	3940	4.32
OPA2314AIDG4	D	SOIC	8	75	506.6	8	3940	4.32
OPA2314AIDG4.A	D	SOIC	8	75	506.6	8	3940	4.32
OPA2314AIDG4.B	D	SOIC	8	75	506.6	8	3940	4.32
OPA2314AIDGK	DGK	VSSOP	8	80	330	6.55	500	2.88
OPA2314AIDGK.A	DGK	VSSOP	8	80	330	6.55	500	2.88
OPA2314AIDGK.B	DGK	VSSOP	8	80	330	6.55	500	2.88
OPA4314AIPW	PW	TSSOP	14	90	530	10.2	3600	3.5
OPA4314AIPW.A	PW	TSSOP	14	90	530	10.2	3600	3.5

**DRB 8**

**GENERIC PACKAGE VIEW**

**VSON - 1 mm max height**

PLASTIC SMALL OUTLINE - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4203482/L

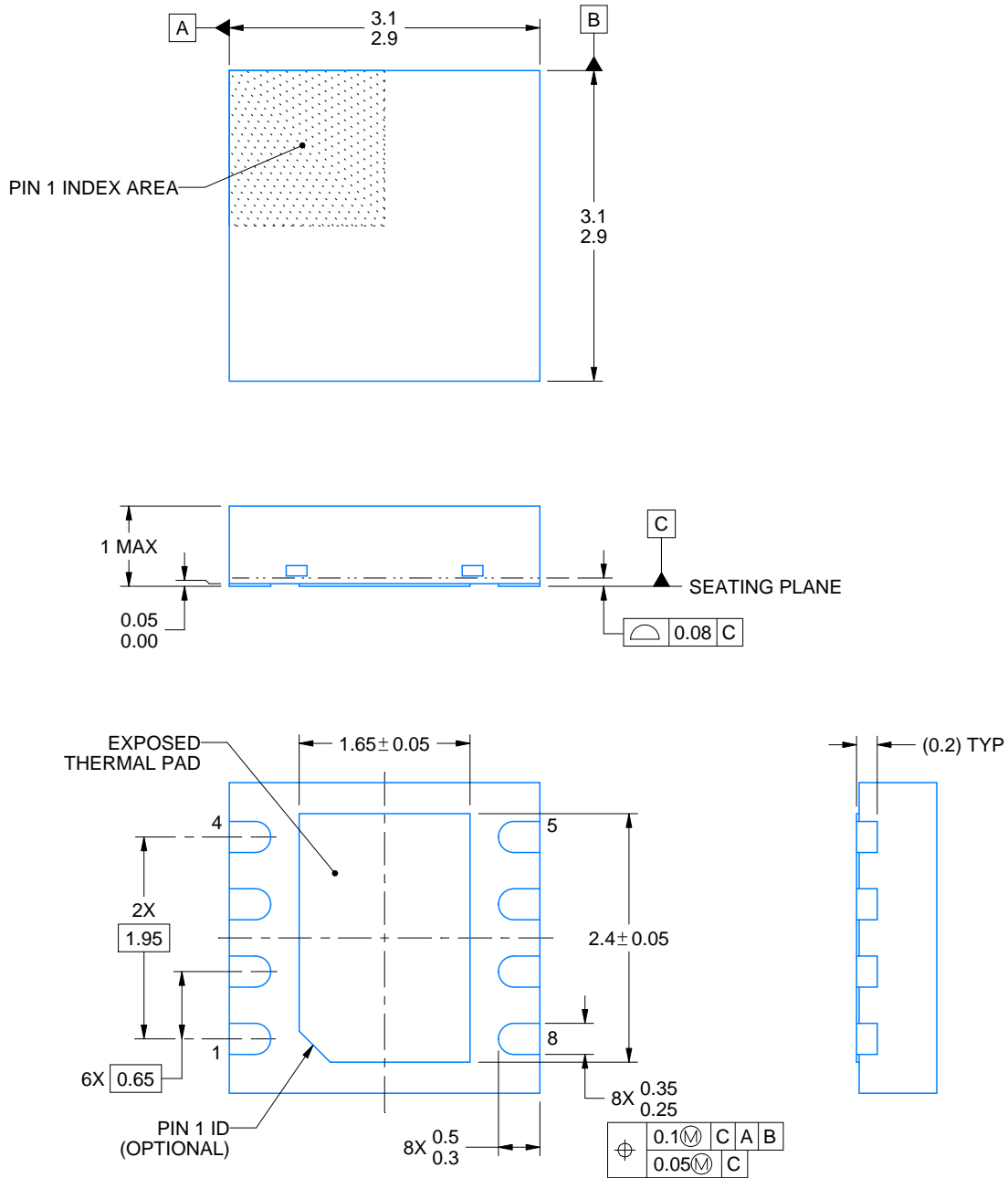
DRB0008B



# PACKAGE OUTLINE

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4218876/A 12/2017

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

# EXAMPLE BOARD LAYOUT

DRB0008B

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
SCALE:20X



SOLDER MASK DETAILS

4218876/A 12/2017

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/sluea271](http://www.ti.com/lit/sluea271)).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



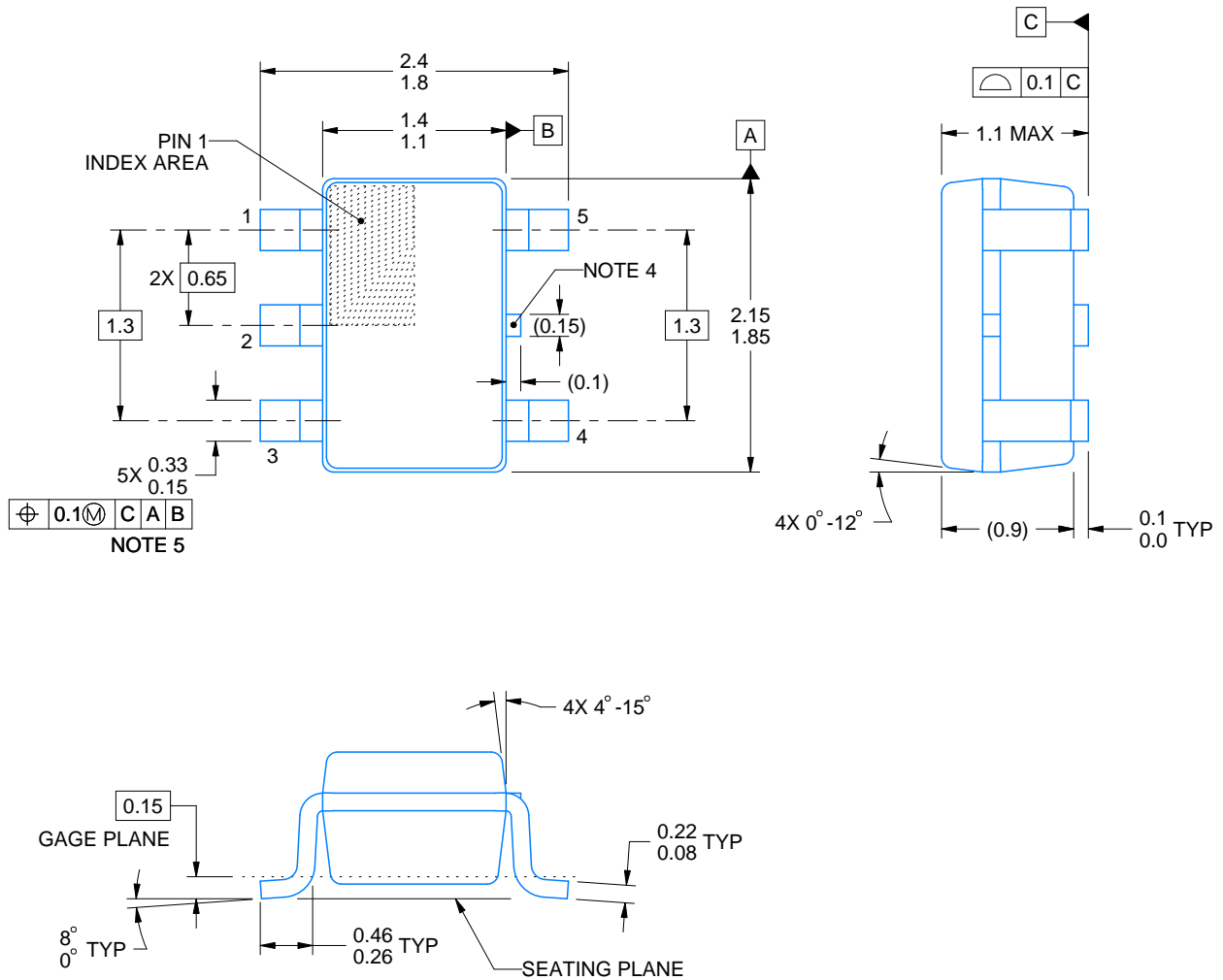
# DCK0005A



# PACKAGE OUTLINE

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



4214834/G 11/2024

## NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC MO-203.
4. Support pin may differ or may not be present.
5. Lead width does not comply with JEDEC.
6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side

# EXAMPLE BOARD LAYOUT

DCK0005A

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:18X



SOLDER MASK DETAILS

4214834/G 11/2024

NOTES: (continued)

- 7. Publication IPC-7351 may have alternate designs.
- 8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DCK0005A

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 THICK STENCIL  
SCALE: 18X

4214834/G 11/2024

NOTES: (continued)

9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
10. Board assembly site may have different recommendations for stencil design.



D0008A

# PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

### NOTES:

- Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed  $.006$  [0.15] per side.
- This dimension does not include interlead flash.
- Reference JEDEC registration MS-012, variation AA.

# EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.125 MM] THICK STENCIL  
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



4220202/B 12/2023

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



4220202/B 12/2023

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220202/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



# EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:15X



SOLDER MASK DETAILS

4214839/K 08/2024

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:15X

4214839/K 08/2024

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



# EXAMPLE BOARD LAYOUT

DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 15X



SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

# EXAMPLE STENCIL DESIGN

DGK0008A

<sup>TM</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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